Application/Control No. Applicant(s)/Patent Under Reexamination 10/518,299 WATANABE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 2612 Van T. Trieu **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-6,927,738 08-2005 343/787 Senba et al. US-6,861,992 03-2005 Kawakami et al. 343/741 В US-5,982,284 340/572.8 С 11-1999 Baldwin et al. US-D US-Ε US-F US-G н US-USı US-J US-K US-US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Classification Country Name Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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